

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination GORDON ET AL.	
		Examiner Jason J. Chung	Art Unit 2611	Page 1 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,614,843	09-2003	Gordon et al.	375/240.01
	B	US-2003/0217360	11-2003	Gordon et al.	725/54
	C	US-6,651,252	11-2003	Gordon et al.	725/54
	D	US-6,481,012	11-2002	Gordon et al.	725/54
	E	US-2003/0208759	11-2003	Gordon et al.	725/46
	F	US-2003/0028879	02-2003	Gordon et al.	725/39
	G	US-2002/0078449	06-2002	Gordon et al.	725/41
	H	US-5,926,230	07-1999	Niijima et al.	725/56
	I	US-2002/0066101	05-2002	Gordon et al.	725/43
	J	US-2001/0056577	12-2001	GORDON et al.	725/52
	K	US-6,621,870	09-2003	Gordon et al.	375/240.28
	L	US-2002/0078440	06-2002	Feinberg et al.	725/9
	M	US-5,642,153	06-1997	Chaney et al.	725/40

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited		Application/Control No. 09/729,660	Applicant(s)/Patent Under Reexamination GORDON ET AL.	
		Examiner Jason J. Chung	Art Unit 2611	Page 2 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,841,433	11-1998	Chaney, John William	725/50
	B	US-5,867,207	02-1999	Chaney et al.	725/54
	C	US-6,415,437	07-2002	Ludvig et al.	725/41
	D	US-6,675,385	01-2004	Wang, Jeffrey Yutong	725/39
	E	US-6,380,984	04-2002	Inoue et al.	348/569
	F	US-6,064,378	05-2000	Chaney et al.	725/39
	G	US-5,822,014	10-1998	Steyer et al.	725/41
	H	US-5,247,363	09-1993	Sun et al.	348/616
	I	US-5,729,279	03-1998	Fuller, William H.	725/74
	J	US-5,485,221	01-1996	Banker et al.	348/563
	K	US-5,946,045	08-1999	Ozkan et al.	725/54
	L	US-5,596,373	01-1997	White et al.	348/569
	M	US-6,504,576	01-2003	Kato, Motoki	375/240.27

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 09/729,660	Applicant(s)/Patent Under Reexamination GORDON ET AL.
	Examiner Jason J. Chung	Art Unit 2611

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,510,842	04-1996	Phillips et al.	375/240.25
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.